

# 54F/74F139 Dual 1-of-4 Decoder/Demultiplexer

#### **General Description**

The 'F139 is a high-speed, dual 1-of-4 decoder/demultiplexer. The device has two independent decoders, each accepting two inputs and providing four mutually exclusive active LOW outputs. Each decoder has an active LOW Enable input which can be used as a data input for a 4-output demultiplexer. Each half of the 'F139 can be used as a function generator providing all four minterms of two variables.

#### **Features**

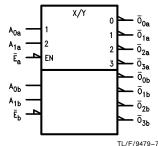
- Multifunction capability
- Two completely independent 1-of-4 decoders
- Active LOW mutually exclusive outputs
- Guaranteed 4000V minimum ESD protection

Commercial	Military	Package Number	Package Description		
74F139PC		N16E	16-Lead (0.300" Wide) Molded Dual-In-Line		
	54F139DM (Note 2)	J16A	16-Lead Ceramic Dual-In-Line		
74F139SC (Note 1)		M16A	16-Lead (0.150" Wide) Molded Small Outline, JEDEC		
74F139SJ (Note 1)		M16D	16-Lead (0.300" Wide) Molded Small Outline, EIAJ		
	54F139FM (Note 2)	W16A	16-Lead Cerpack		
	54F139LM (Note 2)	E20A	20-Lead Ceramic Leadless Chip Carrier, Type C		

Note 1: Devices also available in 13" reel. Use suffix = SCX and SJX.

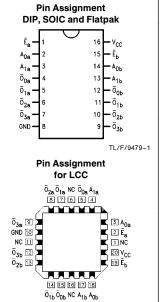
Note 2: Military grade device with environmental and burn-in processing. Use suffix = DMQB, FMQB and LMQB.

# Logic Symbols E A<sub>0</sub> A<sub>1</sub> DECODER a O<sub>0</sub> O<sub>1</sub> O<sub>2</sub> O<sub>3</sub> O O<sub>1</sub> O<sub>2</sub> O<sub>3</sub> TL/F/9479-3 IEEE/IEC X/Y A<sub>0a</sub> 1 DECODER b O<sub>0</sub> O<sub>1</sub> O<sub>2</sub> O<sub>3</sub> O<sub>0</sub> O<sub>1</sub> O<sub>2</sub> O<sub>3</sub> TL/F/9479-4



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#### **Connection Diagrams**



TL/F/9479-2

### **Unit Loading/Fan Out**

		54F/74F			
Pin Names	Description	U.L. HIGH/LOW	Input I <sub>IH</sub> /I <sub>IL</sub> Output I <sub>OH</sub> /I <sub>OL</sub>		
$ \begin{array}{c} A_0, A_1 \\ \overline{E} \\ \overline{O}_0 - \overline{O}_3 \end{array} $	Address Inputs Enable Inputs (Active LOW) Outputs (Active LOW)	1.0/1.0 1.0/1.0 50/33.3	20 μA/ - 0.6 mA 20 μA/ - 0.6 mA - 1 mA/20 mA		

#### **Functional Description**

The 'F139 is a high-speed dual 1-of-4 decoder/demultiplexer. The device has two independent decoders, each of which accepts two binary weighted inputs  $(A_0-A_1)$  and provides four mutually exclusive active LOW Outputs  $(\overline{O}_0-\overline{O}_3)$ . Each decoder has an active LOW enable ( $\overline{E}$ ). When  $\overline{E}$  is HIGH all outputs are forced HIGH. The enable can be used

as the data input for a 4-output demultiplexer application. Each half of the 'F139 generates all four minterms of two variables. These four minterms are useful in some applications, replacing multiple gate functions as shown in *Figure 1*, and thereby reducing the number of packages required in a logic network.

#### **Truth Table**

	Inputs		Outputs					
Ē	A <sub>0</sub> A <sub>1</sub>		Ō <sub>0</sub>	$\overline{O}_1$	$\overline{O}_2$	$\overline{O}_3$		
Н	х	Х	Н	Н	Н	Н		
L	L	L	L	Н	Н	Н		
L	Н	L	Н	L	Н	Н		
L	L	Н	Н	Н	L	Н		
L	Н	Н	Н	Н	Н	L		

H = HIGH Voltage Level

L = LOW Voltage Level

X = Immaterial

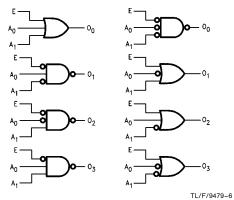
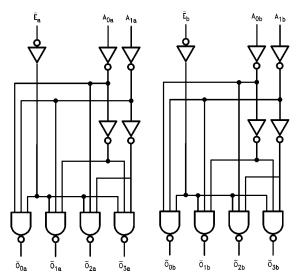


FIGURE 1. Gate Functions (each half)

#### **Logic Diagram**



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

#### **Absolute Maximum Ratings** (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

 $\begin{array}{lll} \mbox{Storage Temperature} & -65^{\circ}\mbox{C to} + 150^{\circ}\mbox{C} \\ \mbox{Ambient Temperature under Bias} & -55^{\circ}\mbox{C to} + 125^{\circ}\mbox{C} \\ \mbox{Junction Temperature under Bias} & -55^{\circ}\mbox{C to} + 175^{\circ}\mbox{C} \\ \mbox{Plastic} & -55^{\circ}\mbox{C to} + 150^{\circ}\mbox{C} \\ \end{array}$ 

V<sub>CC</sub> Pin Potential to

Voltage Applied to Output in HIGH State (with  $V_{CC} = 0V$ )

 $\begin{array}{lll} \text{Standard Output} & -0.5 \text{V to V}_{CC} \\ \text{TRI-STATE} \tiny{\$} \text{ Output} & -0.5 \text{V to } +5.5 \text{V} \end{array}$ 

Current Applied to Output in LOW State (Max) twice the rated I<sub>OL</sub> (mA) ESD Last Passing Voltage (Min) 4000V

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

# Recommended Operating Conditions

Free Air Ambient Temperature

Supply Voltage

Military + 4.5V to + 5.5V Commercial + 4.5V to + 5.5V

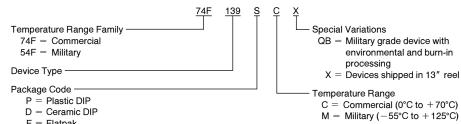
#### **DC Electrical Characteristics**

Symbol	Parameter		54F/74F			Units	vcc	Conditions	
Symbol			Min	Тур	Max	Onits	VCC	Conditions	
$V_{IH}$	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal	
$V_{IL}$	Input LOW Voltage	Input LOW Voltage			0.8	V		Recognized as a LOW Signal	
$V_{CD}$	Input Clamp Diode Vo	oltage			-1.2	V	Min	$I_{IN} = -18 \text{ mA}$	
V <sub>OH</sub>	Output HIGH Voltage	54F 10% V <sub>CC</sub> 74F 10% V <sub>CC</sub> 74F 5% V <sub>CC</sub>	2.5 2.5 2.7			V	Min	$I_{OH} = -1 \text{ mA}$ $I_{OH} = -1 \text{ mA}$ $I_{OH} = -1 \text{ mA}$	
V <sub>OL</sub>	Output LOW Voltage	54F 10% V <sub>CC</sub> 74F 10% V <sub>CC</sub>			0.5 0.5	V	Min	$I_{OL} = 20 \text{ mA}$ $I_{OL} = 20 \text{ mA}$	
I <sub>IH</sub>	Input HIGH Current	54F 74F			20.0 5.0	μΑ	Max	$V_{IN} = 2.7V$	
I <sub>BVI</sub>	Input HIGH Current Breakdown Test	54F 74F			100 7.0	μΑ	Max	V <sub>IN</sub> = 7.0V	
I <sub>CEX</sub>	Output HIGH Leakage Current	54F 74F			250 50	μΑ	Max	V <sub>OUT</sub> = V <sub>CC</sub>	
$V_{ID}$	Input Leakage Test	74F	4.75			٧	0.0	$I_{\text{ID}} = 1.9 \mu\text{A}$ All Other Pins Grounded	
I <sub>OD</sub>	Output Leakage Circuit Current	74F			3.75	μΑ	0.0	V <sub>IOD</sub> = 150 mV All Other Pins Grounded	
I <sub>IL</sub>	Input LOW Current				-0.6	mA	Max	V <sub>IN</sub> = 0.5V	
Ios	Output Short-Circuit Current		-60		<b>-150</b>	mA	Max	V <sub>OUT</sub> = 0V	
Icc	Power Supply Curren		13	20	mA	Max			

#### **AC Electrical Characteristics**

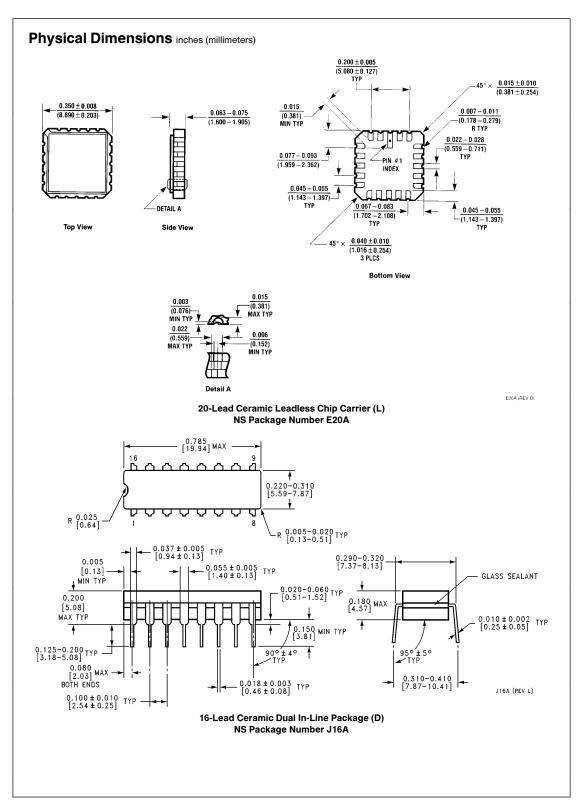
	Parameter	$74F$ $T_{A} = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$			54F  T <sub>A</sub> , V <sub>CC</sub> = Mil  C <sub>L</sub> = 50 pF		74F  T <sub>A</sub> , V <sub>CC</sub> = Com C <sub>L</sub> = 50 pF		Units
Symbol									
		Min	Тур	Max	Min	Max	Min	Max	
t <sub>PLH</sub>	Propagation Delay $A_0$ or $A_1$ to $\overline{O}_n$	3.5 4.0	5.3 6.1	7.5 8.0	2.5 3.5	12.0 9.5	3.0 4.0	8.5 9.0	ns
t <sub>PLH</sub>	Propagation Delay $\overline{E}_1$ to $\overline{O}_n$	3.5 3.0	5.4 4.7	7.0 6.5	3.0 2.5	9.0 8.0	3.5 3.0	8.0 7.5	ns

# **Ordering Information**

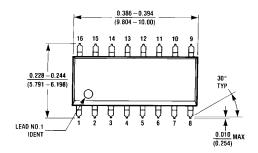


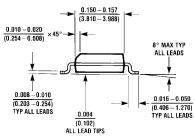
F = Flatpak

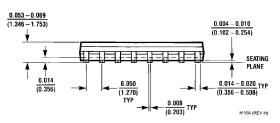
L = Leadless Chip Carrier (LCC)
S = Small Outline SOIC JEDEC
SJ = Small Outline SOIC EIAJ



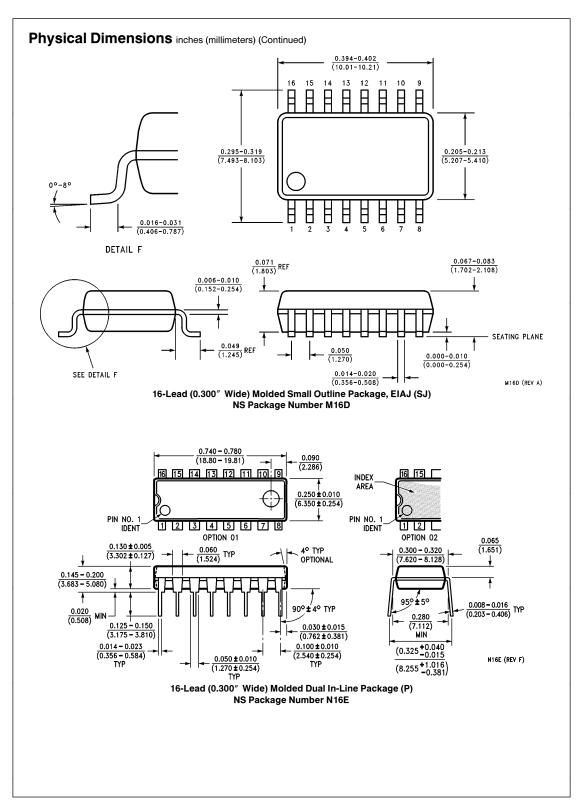
# Physical Dimensions inches (millimeters) (Continued)



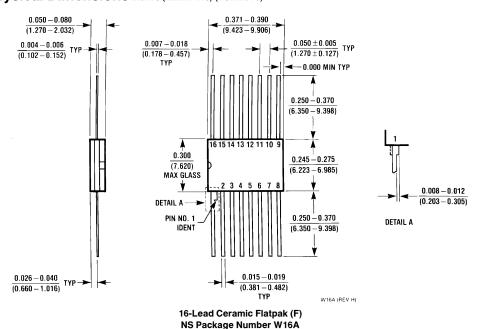




16-Lead (0.150" Wide) Molded Small Outline Integrated Circuit (S) NS Package Number M16A



#### Physical Dimensions inches (millimeters) (Continued)



#### LIFE SUPPORT POLICY

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